SN54LS399, SN74LS399 QUADRUPLE 2-INPUT MULTIPLEXERS WITH STORAGE

- Single-Rail Outputs on 'LS399
- Selects One of Two 4-Bit Data Sources and Stores Data Synchronously with System Clock
- Applications:

Dual Source for Operands and Constants in Arithmetic Processor; Can Release Processor Register Files for Acquiring New Data

Implement Separate Registers Capable of Parallel Exchange of Contents Yet Retain External Load Capability

Universal Type Register for Implementing Various Shift Patterns: Even Has Compound Left-Right Capabilities

description

This monolithic quadruple two-input multiplexer with storage provides essentially the equivalent functional capabilities of two separate MSI functions (SN54LS157/SN74LS157 and SN54LS175/ SN74LS175) in a single 16-pin package.

When the word-select input is low, word 1 (A1, B1, C1, D1) is applied to the flip-flops. A high input to word select will cause the selection of word 2 (A2, B2, C2, D2). The selected word is clocked to the output terminals on the positive-going edge of the clock pulse.

Typical power dissipation is 37 milliwatts. The SN54LS399 is characterized for operation over the full military range of -55 °C to 125 °C. The SN74LS399 is characterized for operation from 0 °C to 70 °C.

FUNCTION TABLE											
	INPUTS			OUTPUTS							
1	WORD ELECT	CLOCK	٥ _A	٥ _B	σc	۵D					
\square	L	1	a1	b1	c1	d1					
·	н	t	a2	b2	c2	d2					
	х	L	Q _{A0}	Q _{B0}	Q _{C0}	Q _{D0}					

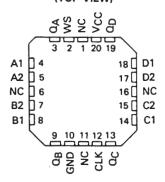
SN54LS399 J OR W PACKAGE SN74LS399 D OR N PACKAGE (TOP VIEW)										
ws (1		Vcc							
Q _A (2	15	QD							
A1 [3	14	D1							
A2	4	13	D2							
B2	5	12	C2							
B1	6	11	C1							
QB	D 7	10	QC							

GND 8

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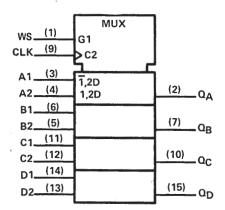


9 CLK



NC - No internal connection

logic symbol[†]



[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

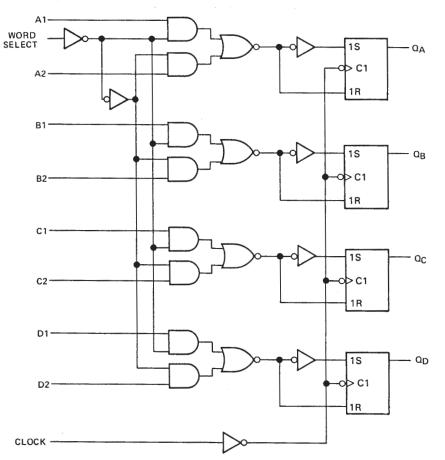
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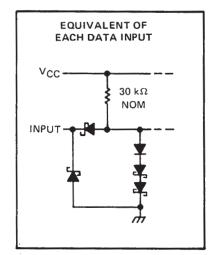
SN54LS399, SN74LS399 QUADRUPLE 2-INPUT MULTIPLEXERS WITH STORAGE

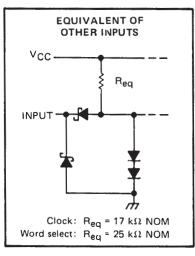
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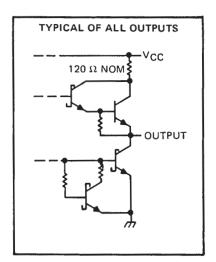
logic diagram (positive logic)



schematics of inputs and outputs









SN54LS399, SN74LS399 QUADRUPLE 2-INPUT MULTIPLEXERS WITH STORAGE

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1) 7 V
Input voltage
Operating free-air temperature range: SN54LS399
SN74LS399
Storage temperature range

NOTE 1: Voltage values are with respect to network ground terminals.

recommended operating conditions

		SN54LS399			SN74LS399			
·		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH				-400			-400	μA
Low-level output current, IOL				4			8	mA
Width of clock pulse, high or low level, tw		20			20			ns
Setup time, t _{su}	Data	25			25			ns
Setup time, t _{su}	Word select	45			45			
Hold time, th	Data	0			0			
	Word select				0			ns
Operating free-air temperature, TA		-55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54LS399			SN74LS399				
		TEST CONDITIONS [†]			MIN	түр‡	MAX	MIN	түр‡	MAX	UNIT
v_{IH}	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.7			0.8	V
, VIK	Input clamp voltage	V _{CC} = MIN,	l _l =18 mA				-1.5			-1.5	V
VOH	High-level output voltage	V _{CC} = MIN, V _{IL} ≈ V _{IL} max	V _{1H} = 2 V, I _{OH} = -400 μA		2.5	3.4		2.7	3.4		v
VOL	Low-level output voltage	V _{CC} = MIN, V _{IL} = V _{IL} max	V _{IH} = 2 V,	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	v
΄η	Input current at maximum input voltage	V _{CC} = MAX,	V ₁ = 7 V	1 _{OL} = 8 mA			0.1		0.35	0.5	mA
ЧН	High-level input current	V _{CC} = MAX,	V _I = 2.7 V				20			20	μA
ΊL	Low-level input current	V _{CC} = MAX,	V _I = 0.4 V				-0.4			0.4	mA
IOS	Short-circuit output current§	V _{CC} = MAX			-20		-100	-20		-100	mA
1CC	Supply current	V _{CC} = MAX,	See Note 2	•		7.3	13		7.3	13	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]All typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

\$Not more than one output should be shorted at a time, duration of the short-circuit should not exceed one second .

NOTE 2: With all outputs open and all inputs except clock low, I_{CC} is measured after applying a momentary 4.5 V, followed by ground, to the clock input.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

PARAMETER		TEST CONDITIONS	MIN	түр	MAX	UNIT
^t PLH	Propagation delay time, low-to-high-level output	$C_L = 15 \text{pF}, R_L = 2 \text{k}\Omega$,	18	27	
^t PHL	Propagation delay time, high-to-low-level output	See Note 3		21	32	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



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